
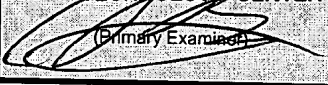


Issue Classification 	Application N .	Applicant(s)	
	09/719,933	WIDL ET AL.	
	Examin r	Art Unit	
	Seung H Lee	2876	

ISSUE CLASSIFICATION									
ORIGINAL				CROSS REFERENCE(S)					
CLASS		SUBCLASS		CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)				
235		384		235	379	380	472.02		
INTERNATIONAL CLASSIFICATION									
G	0	7	B	15/02					
				/					
				/					
				/					
				/					

Seung H Lee 5/28/2004 (Assistant Examiner) (Date)	MICHAEL G. LEE SUPERVISORY PATENT EXAMINER TECHNOLOGY CENTER 2800  (Primary Examiner) (Date)	Total Claims Allowed: 20 O.G. Print Claim(s) 18 O.G. Print Fig. 2
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<input type="checkbox"/> Claims renumbered in the same order as presented by applicant										<input type="checkbox"/> CPA		<input type="checkbox"/> T.D.		<input type="checkbox"/> R.1.47	
Final	Original	Final	Original	Final	Original	Final	Original	Final	Original	Final	Original	Final	Original	Final	Original
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	2	15	32		62		92		122		152		182		
	3	16	33		63		93		123		153		183		
	4	17	34		64		94		124		154		184		
	5	18	35		65		95		125		155		185		
	6	19	36		66		96		126		156		186		
	7	20	37		67		97		127		157		187		
	8		38		68		98		128		158		188		
	9		39		69		99		129		159		189		
	10		40		70		100		130		160		190		
	11		41		71		101		131		161		191		
	12		42		72		102		132		162		192		
	13		43		73		103		133		163		193		
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	15		45		75		105		135		165		195		
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